

Inventor: Brent A. McClure et al
Title: Capacitor Constructions and Methods of Forming
Assignee: Micron Technology, Inc.
Docket No.: MI22-2067

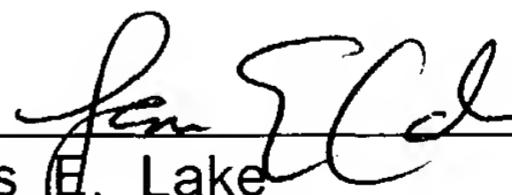
INFORMATION DISCLOSURE STATEMENT

References – See Attached Form PTO-1449

The citations listed, copies attached, may be material to the examination of the subject application and are therefore submitted in compliance with the duty of disclosure defined in 37 CFR § 1.56. The Examiner is requested to make these citations of official record in this application. No admission is made regarding whether all the submitted references are prior art.

The materials cited are presented to assist in and expedite examination of this application. The present invention is considered to be patentable over the cited materials. Expeditious examination and allowance of this application as a patent are therefore urged in order that the public may benefit from the disclosure and commercialization of the invention.

Respectfully submitted,

Dated: 21 Jul 2003 Attorney: 
James E. Lake
Reg. No. 44,854

Form PTO-1449				U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2067		SERIAL NO. Filed Herewith	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Brent A. McClure et al					
				FILING DATE Filed Herewith		GROUP Unknown			
U.S. PATENT DOCUMENTS									
*Examiner Initial		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate	
	AA	6,180,481	1/01	DeBoer et al					
	AB	6,218,256	4/01	Agarwal					
	AC	6,204,049	8/00	Solayappan					
	AD	6,180,447	1/01	Park					
	AE	6,274,428	8/01	Wu					
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	AG	6,144,060	11/00	Park					
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	AJ	6,204,172	9/98	Marsh					
	AK	5,432,732	7/95	Ohmi					
	AL	6,242,299	06/01	Hickert					
FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country		Class	Subclass	Translation	
								Yes	No
	AM								
	AN								
	AO								
	AP								
	AQ								
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)									
	AR		A.W. Ott, et al., "Atomic layer controlled deposition of Al ₂ O ₃ films using binary reaction sequence chemistry" Applied Surface Science (107) 1996, pps. 128-136.						
	AS								
EXAMINER				DATE CONSIDERED					
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>									

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U.S. PATENT DOCUMENTS								
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	AA	6,249,056	06/01	Kwon				
	AB	6,291,289	09/01	Rhodes				
	AC	6,174,770	01/01	Chi				
	AD	5,641,984	06/97	Aftergut et al				
	AE	6,218,260	04/01	Lee et al				
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	AK	6,420,230	07/02	Derderian et al				
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U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	2001/0024387A1	09/01	Raaijmakers et al				
	AB	2002/0064915A1	05/02	Kitamura				
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	AE	09/653,149		Derderian (as filed and amended)			08/00	
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